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PT种子层对微力传感器性能的影响

作 者: 孟汉柏2, 崔岩1, 王兢3, 陈会林2, 王立鼎2

单 位: 1.大连理工大学精密与特种加工教育部重点实验室, 2. 大连理工大学微纳米技术及系统辽宁省重点实验室, 3.大连理工大学电子与信息工程学院基金项目。

摘 要:

为了提高微牛顿量级微力传感器的灵敏度,比较了有PT种子层和无PT种子层的PZT压电薄膜对微力传感器性能的影响。运用Sol-Gel(溶胶-凝胶)法制作了PZT和PT/PZT/PT薄膜,采用X射线衍射技术表征了PZT和PT/PZT/PT两种薄膜的成相特征,用半导体参数测试仪测试了PZT和PT/PZT/PT两种薄膜的漏电流。结果表明,在同为600℃退火温度下,两种薄膜均具有钙钛矿结构,而且PT/PZT/PT薄膜沿(100)晶向强烈取向。当外加电压增加时,PZT薄膜的漏电流基本保持不变;PT/PZT/PT薄膜的漏电流变化在1nA左右。最后应用MEMS工艺分别制作了基于PZT,PT/PZT/PT压电薄膜微悬臂梁结构的微力传感器,并在静态和准静态下对微力传感器的传感特性进行了测试。测试结果表明,添加PT种子层对悬臂梁的弹性常数基本没有影响,但微悬臂梁的灵敏度显著增加。

关键词: PZT薄膜; PT/PZT/PT薄膜; 微悬臂梁; 微力传感器; 压电系数

Influence of the PT seeding layer to the properties of the microforce sensor

Author's Name: MENG Han-bai 2,CUI Yan1, WANG Jing3, CHEN Hui-lin2, WANG Li-ding2

Institution: 1.Key Laboratory for Precision and Non-traditional Machining Technology of Ministry of Education, Dalian University of Technology, 2.Key laboratory for Micro/Nano Technology and System of Liaoning Province, Dalian University of Technology, 3.....

Abstract

For improving the sensitivity of the micro-Newton level force sensor, the properties of the microforce sensors with PT seeding layer and without PT seeding layer piezoelectric PZT thin film were compared. The PZT and PT/PZT/PT thin films were fabricated using sol-gel method and investigated using X-ray diffraction; the leakage current property of them was measured. The result shows that the two kinds of thin film had perovskite tetragonal structure and the PT/PZT/PT thin film strongly oriented in pervoskite (100) at the same 600° C anneal temperature. As the applied voltage increases, the leakage current of the PZT thin film remained basically unchanged, the leakage current of the PT/PZT/PT thin film was retained about 1nA. The microforce sensors based on the PZT, PT/PZT/PT thin films with microcantilever structure were fabricated using MEMS technics at last. The sensing properties of microforce sensor were measured in static state and in quasi-static state. The result showed that their spring constants had no change whether the PT seeding layer was appended.

Keywords: PZT thin film, PT/PZT/PT thin film, Microcantilevers, Microforce sensors, piezoelectric constant

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